

<b>Notice of References Cited</b>	Application/Control No. 10/633,906		Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
	Examiner Jennifer C. McNeil		Art Unit 1775	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,641,941	11-2003	Yamada et al.	428/702
*	B	US-2001/0003271	06-2001	Otsuki, Hayashi	118/723.001
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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